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IS 7098-2 (2011): Crosslinked Polyethylene Insulated Thermoplastics Sheathed Cables, Part 2: for Working Voltages from 3.3 kV up to and Including 33 kV [ETD 9: Power Cables]

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क्रासलिंकड पॉलिथीलीन विद्युत रोधित थर्मोप्लास्टिक की खोल वाली केबल — विशिष्टि

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Indian Standard

## CROSSLINKED POLYETHYLENE INSULATED THERMOPLASTIC SHEATHED CABLES — SPECIFICATION

PART 2 FOR WORKING VOLTAGES FROM 3.3 kV UP TO AND INCLUDING 33 kV

(Second Revision)

ICS 29.060.20

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BUREAU OF INDIAN STANDARDS MANAK BHAVAN, 9 BAHADUR SHAH ZAFAR MARG NEW DELHI 110002

**Price Group 7** 

#### FOREWORD

This Indian Standard (Part 2) (Second Revision) was adopted by the Bureau of Indian Standards, after the draft finalized by the Power Cables Sectional Committee had been approved by the Electrotechnical Division Council.

This standard was originally published in 1973 and subsequently revised in 1985. This revision has been undertaken to bring it in line with International practices. The following changes have been incorporated in this revision:

- a) A special category cables with improved fire performance has been included in this standard. Classification has been given.
- b) Strippability test for semi conducting insulation screen incorporated.
- c) In insulation eccentricity and ovality has been included along with test method.
- d) In outer sheath polyethylene material has been included.
- e) Test voltages have been enhanced in line with IEC 60502-2.
- f) Partial discharge test voltage has been increased to  $1.73U_0$  from 1.5  $U_0$  and sensitivity has been enhanced in line with IEC 60502-2.

This standard is one of the series of Indian Standards on cross-linked polyethylene insulated thermoplastic sheathed cables. Other parts in the series are:

- Part 1 For working voltage up to and including 1 100 V
- Part 3 For working voltages from 66 kV up to and including 220 kV

Particular attention has been drawn to the limitations of the short circuit ratings of the types of cables covered by this standard owing to the absence of the metallic sheath and the possible loss of electrical contacts between the strands of armour as a result of corrosion or presence of compound between them or both. A separate standard about recommended short circuit ratings of these cables is under formulation.

Attention is also drawn to the fact that the current ratings of the types of cables covered by this standard are different from those of the paper insulated metal sheathed cables.

The correct type of cables should be selected for the system keeping in view whether the system is earth or unearthed.

NOTE — It should be realized that in an electric system where an earth fault is not automatically and promptly eliminated the extra stress on the insulation of the cables during the earth faults reduces the life of cables to a certain extent. Therefore if the system is expected to be operated quite often with prolonged earth fault it is advisable to select cables suitable for unearthed system.

In the formulation of this standard assistance has been derived from IEC 60502-2 (2005) 'Power cables with extruded insulation and their accessories for rated voltages from 1 kV up to 30 kV — Part 2: Cables for rated voltages from 6 kV up to 30 kV' issued by the International Electrotechnical Commission.

For the purpose of deciding whether a particular requirement of this standard is complied with the final value observed or calculated expressing the result of the test shall be rounded off in accordance with IS 2 : 1960 'Rules for rounding off numerical values (*revised*)'. The number of significant places retained in the rounded off value should be the same as that of the specified value in this standard.

## Indian Standard

## CROSSLINKED POLYETHYLENE INSULATED THERMOPLASTIC SHEATHED CABLES — SPECIFICATION

## PART 2 FOR WORKING VOLTAGES FROM 3.3 kV UP TO AND INCLUDING 33 kV

(Second Revision)

#### **1 SCOPE**

**1.1** This standard (Part 2) covers the requirements of following categories of crosslinked polyethylene insulated and PVC sheathed or polyethylene sheathed cables for single phase or three phase (earthed or unearthed) systems for electricity supply purposes:

- a) Types of Cables
  - 1) Single-core unscreened, unarmoured (but non-magnetic metallic tape covered);
  - 2) Single-core screened, unarmoured;
  - 3) Single-core armoured (non-magnetic) screened or unscreened; and
  - 4) Three-core armoured, screened or unscreened.
- b) Voltage Grade  $(U_o/U)$ 
  - Earthed systems: 1.9/3.3 kV, 3.8/6.6 kV, 6.35/11 kV, 12.7/22 kV and 19/33 kV.
- 2) *Unearthed system:* 3.3/3.3kV and 11/11kV. NOTES

1 Cables of 6.35/11kV grade (earthed systems) are suitable for use on 6.6/6.6 kV and (unearthed system) also.

**2** The cables conforming to this standard may be operated continuously at a power frequency voltage 10 percent higher than rated voltage.

**3** Under rule 54 of the Indian Electricity Rules, 1956 in case of high voltage, the permissible variation of declared voltage at the point of commencement of supply is not to vary by more than 6 percent on the higher side or by more than 9 percent on the lower side,

**4** Measures taken for achieving longitudinal water tightness shall be as agreed between the purchaser and the supplier.

**1.2** These cables are suitable for use where sum of ambient temperature and temperature rise due to load results in conductor temperature not exceeding 90°C under normal operation and 250°C under short-circuit conditions.

**1.3** Armoured cables up to 11 kV grade specified in this standard are suitable for use in mines also. However, for such cables, additional requirements have been included, wherever necessary (**4.1.1**, **17.5** and **21.2.1**).

**1.4** This standard also covers cables with improved fire performance categories C1 and C2 as given in Annex A. For such cables additional requirements have been included, wherever necessary.

#### **2 REFERENCES**

The following standards contain provisions which, through reference in this text, constitute provisions of this standard. At the time of publication, the editions indicated were valid. All standards are subject to revision and parties to agreements based on this standard are encouraged to investigate the possibility of applying the most recent editions of the standards indicated below:

IS No.	Title
1885 (Part 32) :	Electrotechnical vocabulary: Part 32
1993/IEC 50-	Electric cables
461 : 1984	
3975 : 1999	Mild steel wires, formed wires and
	tapes for armouring of cables
4905 : 1968	Methods for random sampling
5831 : 1984	PVC insulation and sheath of electric cables
8130 : 1984	Conductors for insulated electric cables and flexible cords
10418 : 1982	Drums for electric cables
10462	Fictitious calculation method for
(Part 1) : 1983	determination of dimensions of
	protective coverings of cables: Part 1
	Elastomeric and thermoplastic
10010	insulated cables
10810	Methods of test for cables:
(Part 1) : 1984	Annealing test for wires used in conductors
(Part 2) : 1984	Tensile test for aluminium wires
(Part 3) : 1984	Wrapping test for aluminium wires
(Part 5) : 1984	Conductor resistance test
(Part 6) : 1984	Thickness of thermoplastic and
	elastomeric insulation and sheath
(Part 7): 1984	Tensile strength and elongation at
	break of thermoplastic and
	elastomeric insulation and sheath

#### IS 7098 (Part 2): 2011

IS No.	Title
(Part 10): 1984	Loss of mass test
(Part 11): 1984	Thermal ageing in air
(Part 12): 1984	Shrinkage test
(Part 14) : 1984	Heat shock test
(Part 15): 1984	Hot deformation test
(Part 30) : 1984	Hot set test
(Part 32): 1984	Carbon content test for polyethylene
(Part 33): 1984	Water absorption test (gravimetric)
(Part 36): 1984	Dimensions of armouring material
(Part 37): 1984	Tensile strength and elongation at
	break of armouring materials
(Part 38): 1984	Torsion test on galvanized steel wires
	for armouring
(Part 39) : 1984	Winding test on galvanized steel
	strips for armouring
(Part 40) : 1984	Uniformity of zinc coating on steel
	armour
(Part 41) : 1984	Mass of zinc coating on steel armour
(Part 42) : 1984	Resistivity test of armour wires and
	strips and conductance test of armour
	(wires/strips)
(Part 43) : 1984	Insulation resistance
(Part 45) : 1984	High voltage test
(Part 46) : 1984	Partial discharge test
(Part 47) : 1984	Impulse test
(Part 48) : 1984	Dielectric power factor test
(Part 49) : 1984	Heating cycle test
(Part 50) : 1984	Bending test
(Part 53) : 1984	Flammability test
(Part 58) : 1998	Oxygen index test
(Part 59) : 1988	Determination of the amount of
	halogen acid gas evolved during
	combustion of polymeric materials
	taken from cables
(Part 60) : 1988	Thermal stability of PVC insulation
(D (1) 1000	and sheath
(Part 61) : 1988	Flame retardant test
(Part 62) : 1993	Fire resistance test for bunched
	capies

(Part 64): 2003 Measurement of temperature index

#### **3 TERMINOLOGY**

For the purpose of this standard, the following definitions in addition to those given in IS 1885 (Part 32) shall apply.

**3.1 Routine Test** — Test made by the manufacturer on all finished cable lengths to demonstrate the integrity of the cable.

**3.2 Type Tests** — Tests required to be made before supply on a general commercial basis a type of cable in order to demonstrate satisfactory performance characteristics to meet the intended application.

NOTE — These tests are of such a nature that after they

have been made they need not be repeated unless changes are made in the cable materials or design which might change the performance characteristics.

**3.3 Acceptance Tests** — Tests carried out on samples taken from a lot for the purpose of acceptance of the lot.

**3.4 Optional Tests** — Special tests to be carried out, when required, by agreement between the purchaser and the supplier.

**3.5 Earthed System** — An electric system which fulfills any of the following conditions:

- a) Neutral-point or the mid-point connection is earthed in such a manner that, even under fault conditions, the maximum voltage that can occur between any conductor and the earthed does not exceed 80 percent of the nominal system voltage; and
- b) The neutral-point or the mid-point connection is not earthed but a protective device is installed which automatically cuts out any part of the system which accidentally becomes earthed within a duration of 1 min; or
- c) In case of ac systems only, the neutral-point is earthed through an arc suppression coil with arrangement for isolation within 1 h of occurrence of the fault for the non-radial field cables and within 8 h for radial cables, provided that the total of such periods in a year does not exceed 125 h.

**3.6 Unearthed Systems** — An electric system which does not fulfill the requirement of the earthed systems (*see* **3.5**).

#### **4 CONDUCTOR**

**4.1** The conductors shall be composed of plain copper or aluminium wires complying with IS 8130.

**4.1.1** Mining cables to be used in gassy mines shall be of copper conductor only.

#### **5 INSULATION**

The insulation shall be of cross linked polyethylene conforming to the requirement given in Table 1.

#### **6 SCREENING**

**6.1** The screening shall consist of one or more of the following, as specified:

- a) Non-metallic semi-conducting tape,
- b) Non-metallic semi-conducting compound, and
- c) Non-magnetic metallic tape wire, strip or sheath.

NOTE — The semi-conducting tape and semi-conducting compound shall be suitable for the operating temperature of the cable and compatible with the insulating material.

#### **Table 1 Properties of XLPE Insulation** (*Clause* 5)

Sl No.	Property	Requirements
(1)	(2)	(3)
i)	Tensile strength	12.5 N/mm <sup>2</sup> , Min
ii)	Elongation at break	200 percent, Min
iii)	Ageing in air oven:	
	a) Treatment (Temperature	135 ± 3 °C
	CDuration)	7 day
	b) Tensile strength variation	$\pm 25$ percent, Max
	c) Elongation variation	$\pm 25$ percent, Max
iv)	Hot set test	
	a) Treatment:	
	1) Temperature	$200 \pm 3 ^{\circ}\text{C}$
	2) Time under load	15 min
	3) Mechinical stress	20 N/cm <sup>2</sup>
	b) Elongation under load	175 percent, Max
	c) Permanent elongation (set)	15 percent, Max
``	after cooling	
V)	Shrinkage:	120 . 2.00
	a) Treatment (Temperature	$130 \pm 3$ °C
	$\sim$ Duration):	lh
	b) Shrinkage	4 percent, Max
vi)	Water absorption (Gravimetric):	
	a) Treatment ∫(Temperature	85 ± 2 °C
	Upuration)	14 days
	b) Water absorbed	1 mg/cm <sup>2</sup> , Max
vii)	Volume resitivity	
, í	a) at 27 °C	$1 \times 10^{14} \Omega$ cm, Min
	b) at 90 °C	$1 \times 10^{12} \Omega$ cm, <i>Min</i>

#### 6.1.1 Non-metallic — Semiconducting Compound

The material shall be bonded or strippable type conforming to the requirements given in Table 2. Unless otherwise specified it shall be bonded type.

Table 2 Properties of Extruded Semiconducting Screen

Sl No	Property	Requirements
•		
(1)	(2)	(3)
i)	Strippability test for strippable semiconducting insulation screen	Force required to remove semi- conducting screen from insulation without damaging shall be not less than 4 N or greater than 45 N before and after ageing when test as per Method of Test as per Annex B
ii)	Resistivity test for semiconducting screen: a) Conductor screen b) Core screen	Method of Test as per Annex E 1000 $\Omega$ m, <i>Max</i> 500 $\Omega$ m, <i>Max</i>

## **6.1.2** Non-magnetic Metallic Tape for Single Core Unscreened and Unarmoured Cables

Requirements for this tape shall be as agreed to between the purchaser and the manufacturer.

#### **7 FILLERS AND INNER SHEATH**

**7.1** The fillers and inner sheath shall be of the following:

- a) Vulcanized or unvulcanized rubber; and
- b) Thermoplastic materials.

NOTE — Vulcanized or unvulcanized rubber or thermoplastic material used for inner sheath shall not be harder than XLPE compounds used for insulation and outer sheath respectively. Fillers and inner sheath materials shall be chosen to be compatible with the temperature rating of the cable and shall have no deleterious effect on any other component of the cable.

#### **8ARMOURING**

**8.1** Armouring shall be of the following:

- a) Galvanized round steel wire, and
- b) Galvanized formed wires, or
- c) Any metallic non-magnetic wire/strip.

**8.2** The galvanized steel wires/strip shall comply with the requirements of IS 3975. The requirements of non-magnetic material shall be as agreed to between the purchaser and the supplier.

#### **9 OUTER SHEATH**

The outer sheath shall be of polyvinyl chloride (PVC) or polyethylene conforming to the requirements of Type ST 2 of IS 5831 or Table 3 respectively.

NOTE — For Category C1 and C2 PVC Type ST 2 with suitable additives to be used to meet the requirements of 19.1.3 and 19.2.2.

#### **10 CONDUCTOR**

**10.1** The conductor shall be of stranded construction, size  $25 \text{ mm}^2$  and above complying with Class 2 of IS 8130.

**10.2** In case of 1.9/3.3kV cables, a protective barrier may be applied between the conductor and insulation at the discretion of the manufacturer such barrier, when used shall be compatible with insulating material and suitable for the operating temperature of the cable.

#### **11 CONDUCTOR SCREENING**

**11.1** All cables rated above 1.9/3.3 kV shall be provided with conductor screening. Conductor screening shall be provided over the conductor by extrusion of semiconducting compound or a combination of nonmetallic semi conducting tape and extrusion of semi conducting compound.

#### **12 INSULATION**

**12.1** The conductor (with protective barrier or screen, where applied) shall be provided with cross linked polyethylene insulation applied by extrusion.

## **Table 3 Properties of Thermoplastic**

**Polyethylene Sheath** (*Clause* 9)

SI No.	Property	Requirements	
(1)	(2)	(3)	
i)	<ul><li>Without aging</li><li>a) Tensile strength (N/mm<sup>2</sup>)</li><li>b) Elongation at break</li></ul>	12.5 N/mm <sup>2</sup> , <i>Min</i> 300 percent, <i>Min</i>	
ii)	Ageing in air oven: a) Treatment Temperature Duration	110 ± 2 °C 7 days	
iii)	b) Elongation at break Carbon black content	300 percent, <i>Min</i> $2.5 \pm 0.5$ percent	
iv)	Hot deformation test $110 \pm 2 \degree C$ for 6 h		
	Maximum depth of indentation	50 percent	

#### **12.2 Thickness of Insulation**

The average thickness of insulation shall be not less than the nominal value  $(t_i)$  specified in Table 4

#### 12.3 Tolerance on Thickness of Insulation

The smallest of measured values of thickness of insulation shall not fall below the nominal value  $(t_i)$  specified in Table 4 by more than 0.1 mm + 0.1  $t_i$ .

#### **12.4 Eccentricity and Ovality**

Eccentricity of insulation shall not exceed 15 percent when tested as per Annex A.

#### **12.5 Application of Insulation**

The insulation shall be so applied that it fits closely on the conductor (or conductor screening or barrier if any) and it shall be possible to remove it without damaging the conductor.

#### **13 INSULATION SCREENING**

**13.1** All cables rated above 1.9/3.3 kV shall be provided with insulation screening.

**13.2** The insulation screening shall consist of two parts; namely, metallic and non-metallic.

**13.3** Non-metallic part shall be applied directly over the insulation of each core and shall consist of either extruded semi-conducting compound or a combination of semi-conducting tape and extruded semi-conducting compound. The test method for strippability test for strippable semi-conducting insulation screen is given in Annex B. Semiconducting water swell-able tapes if used shall be as agreed between the purchaser and the supplier.

**13.4** Metallic part shall consist of either tape, or braid, or concentric serving of wires or a combination of wires and tapes or a sheath shall be non-magnetic and shall be applied over the non-metallic part. For single-core armoured cables, the armouring may constitute the metallic part of the screening.

SI No.	Nominal Area of Conductor	Nominal Thickness of Insulation ( <i>t</i> <sub>I</sub> )						
		1.9/3.3 kV an	d 3.3/3.3 kV	3.8/6.6 kV	6.35/11 kV	11/11 kV	12.7/22 kV	19/33kV
	mm <sup>2</sup>	Single Core Armoured Cables mm	Single Core Unarmoured and Three Core Cables mm	mm	mm	mm	mm	mm
(1)	(2)	(3)	(4)	(5)	(6)	(7)	(8)	(9)
i)	25	2.5	2.2	2.8	3.6	5.5	6.0	8.8
ii)	35	2.5	2.2	2.8	3.6	5.5	6.0	8.8
iii)	50	2.5	2.2	2.8	3.6	5.5	6.0	8.8
iv)	70	2.5	2.2	2.8	3.6	5.5	6.0	8.8
v)	95	2.5	2.2	2.8	3.6	5.5	6.0	8.8
vi)	120	2.5	2.2	2.8	3.6	5.5	6.0	8.8
vii)	150	2.5	2.2	2.8	3.6	5.5	6.0	8.8
viii)	185	2.5	2.2	2.8	3.6	5.5	6.0	8.8
ix)	240	2.5	2.2	2.8	3.6	5.5	6.0	8.8
x)	300	2.5	2.2	3.0	3.6	5.5	6.0	8.8
xi)	400	2.6	2.2	3.3	3.6	5.5	6.0	8.8
xii)	500	2.8	2.4	3.5	3.6	5.5	6.0	8.8
xiii)	630	3.0	2.6	3.5	3.6	5.5	6.0	8.8
xiv)	800	3.3	2.8	3.5	3.6	5.5	6.0	8.8
xv)	1 000	3.5	3.0	3.6	3.6	5.5	6.0	8.8

## Table 4 Nominal Thickness of Insulation(Clauses 12.2 and 12.3)

#### **14 CORE IDENTIFICATION**

**14.1** Core identification for three core cables shall be as follows:

Voltage Grade kV	Me	ethod of Identification
1.9/3.3 and 3.3/3.3	a) b) c)	Different colouring of XLPE insulation, or Coloured strips applied on the cores, or By numerals (1, 2, 3,) either by applying numbered strips or by printing on the cores. NOTE — It is permissible to apply the strips above the insulation screen
3.8/6.6, 6.35/11, 11/11, 12.7/22 and 19/33 kV	a) b)	Coloured strips applied on the cores, or By numerals (1, 2, 3) either by applying numbered strips or by printing on the cores

**14.1.1** For identification by using coloured strips, red, yellow and blue colours respectively shall be used to identify phase conductors.

#### **15 LAYING UP OF CORES**

**15.1** In three core cables, the cores shall be laid together with a suitable right hand lay. Where necessary the interstices shall be filled with non-hygroscopic material.

#### 16 INNER SHEATH (COMMON COVERING)

**16.1** The laid up cores shall be provided with inner sheath applied either by extrusion or by wrapping. It shall be ensured that the shape is as circular as possible.

**16.2** The inner sheath shall be so applied that it fits closely on the laid up cores and it shall be possible to remove it without damage to the insulation.

**16.2.1** In case of single core cables where there are both metallic screening and armouring there shall be extruded inner sheath between them.

#### 16.3 Thickness of Inner Sheath

The thickness of inner sheath (common covering) shall be as given in Table 5 single core cables except those specified on **15.2.1** shall have no inner sheath.

**16.3.1** When one or more layers of binder tapes are applied over the laid up cores, the thickness of the tapes shall not be construed as a part of the inner sheath.

#### **17 ARMOURING**

#### **17.1 Application**

Armouring shall be applied over the insulation or

#### **Table 5 Thickness of Inner Sheath**

(*Clause* 16.3)

All dimensions in millimetres.

Sl No.	Calculated Diameter Over Laid Up Cores, Ref to IS 10462 (Part 1)		Thickness of Inner Sheath Min
	Over	Up to and Including	
(1)	(2)	(3)	(4)
i)	_	25	0.3
ii)	25	35	0.4
iii)	35	45	0.5
iv)	45	55	0.6
v)	55	_	0.7

protective barrier or non-metallic part of insulation screening, if any in case of single core cables or over inner sheath in case of screened and armoured single core cables and over inner sheath in case of three cores cables.

**17.1.1** The armour wires/formed wires shall be applied as closely as practicable.

**17.1.2** The direction of lay of armour shall be left hand for double wires/formed wires armoured cable this requirement shall apply to the inner layer of wires/ formed wires the outer layer shall, except in special cases be applied in the reverse direction to the inner layer, and there shall be a separator of suitable non-hygroscopic material: such as plastic tape bituminized Hessian cotton tape, rubber proofed tape between the inner and outer layers of armoured wires/formed wires.

**17.1.3** A binder tape may be applied over the armour.

#### 17.2 Types of Armour

Where the calculated diameter below armouring does not exceed 13 mm, the armour shall consist of galvanized round steel wires. The armour of cables having calculated diameter below armouring greater than 13 mm shall consist of either galvanized round steel wires or galvanized formed wires.

**17.2.1** In case of single-core cables for ac system, the armouring shall be of non-magnetic material.

#### **17.3 Dimensions**

The dimension of galvanized steel wire or formed wires shall be as specified in Table 6.

#### 17.4 Joints

The joints in armour wires or formed wires shall be made by brazing or welding and the surface irregularities shall be removed. A joint in any wires/ formed wires shall be at least 300 mm from the nearest

#### Table 6 Dimensions of Armour — Round Wires and Formed Wires

(*Clause* 17.3)

All dimensions in millimetres.

Sl No.	Calculated Diameter Under Armour [IS 10462 (Part 1)]	Nominal Thickness of Steel Strip	Nominal of Rou	Diameter nd Wire
	Over	Up to and		
(1)	(2)	Including (3)	(4)	(5)
i)	For all diameter in		0.8	—
;;)	excess of 15 or	12		1.4
11)	b) 13	25	0.8	1.4
	c) 25	40	0.8	2.0
	d) 40	55	1.4	2.5
	e) 55	70	1.4	3.15
	f) 70	—	1.4	4.0
N ap	OTE — (i) and (ii) indi	cate two metho g.	ods of prac	tice in the

joint in any other armoured wire/formed wires in the completed cable.

#### 17.5 Resistance

In case of cable for use in mines the resistance of armoured shall be not exceed that of conductor as specified in IS 8130 by more than 33 percent. To satisfy this, substitution of the galvanized steel wires/ formed wires in armour by required number of tinned copper wires/formed wires is permissible.

#### **18 OUTER SHEATH**

**18.1** The outer sheath shall be applied by extrusion. It shall be applied:

- a) Over the non-magnetic metallic tape covering. The insulation or over The nonmagnetic metallic part of insulation screening in case of un-armoured single core cables, and
- b) Over the armouring in case of armoured cables.

**18.2** Colour of outer sheath shall be black or any other colour as agreed to between the purchaser and the supplier.

### 18.3 Thickness of Outer Sheath

#### 18.3.1 Unarmoured Cables

The thickness of outer sheath of unarmoured cables determined by taking the average of a number of measurements shall be not less than the nominal value specified in col 3 of Table 7 and the smallest of the measured values shall not fall below the nominal value specified in col 4 of Table 7.

#### 18.3.2 Armoured Cables

The thickness of outer sheath shall not be less than the minimum value specified in col 5 of Table 7.

#### **Table 7 Thickness of Outer Sheath**

(*Clauses* 18.3.1 and 18.3.2)

All dimensions in millimetres.

SI No.	Calculated Diameter Under the Outer Sheath [IS 1S462 (Part 1)]		Thickness of Outer Sheath for Unarmoured Cables		Minimum Thickness of Outer Sheath for Armoured Cables
	Over	Up to and Including	Nominal (t <sub>s</sub> )	Minimum	
(1)	(2)	(3)	(4)	(5)	(6)
i)	_	15	1.8	1.24	1.24
ii)	15	25	2.0	1.4	1.4
iii)	25	35	2.2	1.56	1.56
iv)	35	40	2.4	1.72	1.72
v)	40	45	2.6	1.88	1.88
vi)	45	50	2.8	2.04	2.04
vii)	50	55	3.0	2.2	2.2
viii)	55	60	3.2	2.36	2.36
ix)	60	65	3.4	2.52	2.52
x)	65	70	3.6	2.68	2.68
xi)	70	75	3.8	2.84	2.84
xii)	75	—	4.0	3.0	3.0

#### **19 CLASSIFICATION OF TESTS**

### 19.1 Type Tests

The following shall constitute type tests:

**19.1.1** Test (viii), (x), (xii) and (xiii), are applicable only to screened cables.

**19.1.2** With the exception and provision of **19.1.1** the following tests on screened cable shall be performed

(1)(2)(3)(4)i)Test on conductor:a)Annealing test (for copper)IS 81301b)Tensile test (for aluminium)IS 81302c)Wrapping test (for aluminium)IS 81303d)Resistance testIS 81305ii)Test for armouring wires/formed wiresClause 7, Table 6 and36-42iii)Physical test for insulation:a)Table 17b)Ageing in air ovenTable 11111c)Degree of cross linking0306d)Hot set testTable 11330e)Shrinkage testTable 11331iv)Test for thickness of insulationClause 11, Tables 4, 5 and6(eccentricity) and sheath7and Annex A7v)Test for strippability of semiconducting screensa)Table 2 and Annex Ea)Tensile strength and elongation at breakIS 5831 or Table 311e)Speing in air ovenIS 5831 or Table 311c)Shrinkage testIS 5831 or Table 311d)Hot deformationIS 5831 or Table 310f)Hear shockIS 583110f)Hear shockIS 583110g)Table 332 or any other thermoa)Test for scinptlyIS 5831 or Table 311e)Shock content of polythenesheath32 or any other thermog)Table 332 or a	Sl No.	Test	For Requirements, Ref to	Method of Test, Ref to IS 10810
i)       Test on conductor:         a)       Annealing test (for copper)       IS 8130       1         b)       Tensile test (for aluminium)       IS 8130       2         c)       Wrapping test (for aluminium)       IS 8130       3         d)       Resistance test       IS 8130       5         ii)       Test for armouring wires/formed wires       Clause 7, Table 6 and 36-42         iii)       Test for insulation:       a)       30         a)       Tesike strength and elongation at break       Table 1       7         b)       Ageing in air oven       Table 1       30         c)       Degree of cross linking       1       30         d)       Hot set test       Table 1       30         e)       Shrinkage test       Table 1       33         iv)       Test for thickness of insulation       Clause 11, Tables 4, 5 and 6       6         (eccentricity) and sheath       7       Table 1       33       1         v)       Test for strippability of semicon-ducting screens       Table 2 and Annex B       1         vi)       Physical test for outer sheath:       a)       15       5831 or Table 3       11         c)       Shrinkage test       IS 58	(1)	(2)	(3)	(4)
a) Annealing test (for copper) IS 8130 1 b) Tensile test (for aluminium) IS 8130 2 c) Wrapping test (for aluminium) IS 8130 3 d) Resistance test IS 8130 5 ii) Test for armouring wires/formed wires Clause 7, Table 6 and 36-42 IS 3975 iii) Physical test for insulation: a) Tensile strength and elongation at break a) Test for armouring wires/formed wires Clause 7, Table 6 and 36-42 IS 3975 iii) Physical test for insulation: a) Tensile strength and elongation at break Table 1 7 b) Ageing in air oven c) Degree of cross linking d) Hot set test Table 1 1 1 c) Degree of cross linking d) Hot set test Table 1 1 1 f) Water absorption test (gravimetric) Table 1 3 iv) Test for thickness of insulation (eccentricity) and sheath 7 and Annex A v) Test on extruded semi conducting screens a) Test for outer sheath: a) Test for outer sheath: a) Test for outer sheath: a) Test for outer sheath: b) Volume resistivity Table 2 and Annex E vi) Physical test for outer sheath: a) Tensile strength and elongation at b) Ageing in air oven (when applicable) b) Volume resistivity Table 2 and Annex E vi) Physical test for outer sheath: a) Tensile strength and elongation at b) Ageing in air oven (IS 5831 or Table 3 11 c) Shrinkage test IS 5831 or Table 3 15 e) Loss of mass in air oven (IS 5831 or Table 3 16 h) Carbon black content of polythene sheath b) As a function of voltage b) As a function of temperature xi) Insulation resistance (volume resistivity) test Table 1 43 xiii) Heat cycle test xi) Insulation resistance (volume resistivity) test Table 1 43 xiii) Impulse withstand test 19.6 47 xiv) High voltage test for 20 45 45 45 45 45 45 45 45 45 45	i)	Test on conductor:		
b) Tensile test (for aluminium) IS 8130 2 c) Wrapping test (for aluminium) IS 8130 3 d) Resistance test IS 8130 5 ii) Test for armouring wires/formed wires Clause 7, Table 6 and 36-42 IS 3975 iii) Physical test for insulation: a) Tensile strength and elongation at break Table 1 7 b) Ageing in air oven Table 1 11 c) Degree of rooss linking d) Hot set test Table 1 30 e) Shrinkage test Table 1 30 e) Shrinkage test Table 1 33 iv) Test for stripability of test (gravimetric) Table 1 33 iv) Test for stripability of semicon- ducting stripable insulation screen (when applicable) b) Volume resistivity Table 2 and Annex B d) Hot deformation IS 5831 or Table 3 7 break b) Ageing in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 07 f) Heat shock IS 5831 07 f) Heat f		a) Annealing test (for copper)	IS 8130	1
<ul> <li>c) Wrapping test (for aluminium)</li> <li>IS 8130</li> <li>d) Resistance test</li> <li>IS 8130</li> <li>Test for armouring wires/formed wires</li> <li>Clause 7, Table 6 and</li> <li>36-42</li> <li>IS 3975</li> <li>iii) Test for insulation:         <ul> <li>a) Testi for insulation:</li> <li>a) Testi for singulation at break</li> <li>Table 1</li> <li>7</li> <li>b) Ageing in air oven</li> <li>Table 1</li> <li>11</li> <li>c) Degree of cross linking</li> <li>d) Hot set test</li> <li>Table 1</li> <li>12</li> <li>f) Water absorption test (gravimetric)</li> <li>Table 1</li> <li>12</li> <li>f) Water absorption test (gravimetric)</li> <li>Table 1</li> <li>33</li> </ul> </li> <li>iv) Test for thickness of insulation</li> <li>Clause 11, Tables 4, 5 and 6</li> <li>(cccentricity) and sheath</li> <li>7 and Annex A</li> </ul> <li>v) Test for strippability of semicon-             <ul> <li>ducting strippable insulation screen</li> <li>(when applicable)</li> </ul> </li> <li>b) Volume resistivity</li> <li>Table 2 and Annex B</li> <li>ducting strippable insulation screen</li> <li>(when applicable)</li> <li>b) Volume resistivity</li> <li>a) Test for strippablity of semicon-         <ul> <li>(a) Testie strength and elongation at IS 5831 or Table 3</li> <li>11</li> <li>c) Shrinkage test</li> <li>IS 5831 or Table 3</li> <li>11</li> <li>c) Shrinkage test</li> <li>IS 5831</li> <li>IA</li> <li>g) Thermal stability</li> <li>IS 5831</li> <li>IS 5831</li> <li>IA</li> <li>g) Thermal ageing test for</li></ul></li>		b) Tensile test (for aluminium)	IS 8130	2
d)Resistance testIS 81305ii)Test for armouring wires/formed wiresClause 7, Table 6 and IS 397536-42iii)Physical test for insulation: a)IS 3975iii)Physical test for insulation: a)Table 17a)Tensile strength and clongation at breakTable 17b)Ageing in air ovenTable 111c)Degree of cross linking d)Hot set testTable 112f)Water absorption test (gravimetric)Table 1336iv)Test for thickness of insulation ducting strippable insulation screen (when applicable)Clause 11, Tables 4, 5 and 7 and Annex A6v)Test or strippability of semicon- ducting strippable insulation screen (when applicable)Table 2 and Annex B11b)Noume resistivityTable 2 and Annex E1312vi)Physical test for outer sheath: a)Table 2 and Annex E11583112d)Hot deformationIS 5831 or Table 31111c)Shrinkage testIS 58311011c)Shrinkage testIS 58311011d)Hot deformationIS 5831143g)Thermal stabilityIS 5831143g)Thermal stabilityIS 5831603032 or any other thermo analytic method (by therm gravimetric analysis)vii)Thermal ageing test for complete cable19.9see 19.914g) <td></td> <td>c) Wrapping test (for aluminium)</td> <td>IS 8130</td> <td>3</td>		c) Wrapping test (for aluminium)	IS 8130	3
ii)       Test for armouring wires/formed wires       Clause 7, Table 6 and IS 3975       36-42         iii)       Physical test for insulation: <ul> <li>a)</li> <li>Testif or insulation:</li> <li>a)</li> <li>Testif estrength and elongation at break</li> <li>Table 1</li> <li>Table 1</li> <li>11</li> <li>c)</li> <li>Degree of cross linking</li> <li>d)</li> <li>Hot set test</li> <li>Table 1</li> <li>12</li> <li>f)</li> <li>Water absorption test (gravimetric)</li> <li>Table 1</li> <li>133</li> <li>iv)</li> <li>Test for thickness of insulation</li> <li>Clause 11, Tables 4, 5 and 6</li> <li>(eccentricity) and sheath</li> <li>7 and Annex A</li> </ul> <ul> <li>Test for strippability of semicon-ducting strippable insulation screen (when applicable)</li> <li>b)</li> <li>Volume resistivity</li> <li>Table 2 and Annex B</li> <li>a)</li> <li>Testif or outer sheath:                  <ul> <li>a)</li> <li>Test for outer sheath:</li></ul></li></ul>		d) Resistance test	IS 8130	5
<ul> <li>iii) Physical test for insulation: <ul> <li>a) Tensile strength and elongation at break</li> <li>Table 1</li> <li>7</li> <li>b) Ageing in air oven</li> <li>c) Degree of cross linking</li> <li>d) Hot set test</li> <li>Table 1</li> <li>30</li> <li>e) Shrinkage test</li> <li>Table 1</li> <li>12</li> <li>f) Water absorption test (gravimetric)</li> <li>Table 1</li> <li>33</li> <li>iv) Test for thickness of insulation</li> <li>(eccentricity) and sheath</li> <li>7 and Annex A</li> </ul> </li> <li>v) Test on extruded semi conducting screens <ul> <li>a) Test for strippability of semicon-ducting streens</li> <li>a) Test for outer sheath: <ul> <li>a) Test for outer sheath:</li> <li>b) Volume resistivity</li> <li>Table 2 and Annex B</li> <li>clause 11, Table 3</li> <li>7 break</li> </ul> </li> <li>b) Volume resistivity</li> <li>Table 2 and Annex E</li> <li>vi) Physical test for outer sheath: <ul> <li>a) Test for outer sheath:</li> <li>a) Testif extended semi conducting screens</li> </ul> </li> <li>b) Volume resistivity</li> <li>Table 2 and Annex E</li> <li>vi) Physical test for outer sheath: <ul> <li>a) Testif extended semi conducting screens</li> <li>b) Ageing in air oven</li> <li>IIS 5831 or Table 3</li> <li>11</li> <li>c) Shrinkage test</li> <li>IIS 5831 or Table 3</li> <li>11</li> <li>c) Shrinkage test</li> <li>IIS 5831 or Table 3</li> <li>15</li> <li>c) Loss of mass in air oven</li> <li>IIS 5831</li> <li>10</li> <li>f) Heat shock</li> <li>IIS 5831</li> <li>f) Carbon black content of polythene Table 3</li> <li>32 or any other thermo analytic method (by therm gravimetric analysis)</li> <li>vii) Thermal ageing test for complete cable</li> <li>19.9</li> <li>see 19.9</li> </ul> </li> <li>viii) Insulation resistance (volume resistivity) test</li> <li>Table 1</li> <li>43</li> <li>a) As a function of temperature</li> <li>xi) Insulation fersipterature</li> <li>xii) Heat cycle test</li> <li>19.6</li> <li>47</li> <li>xiii) Heat cycle test</li> <li>19.6</li> <li>47</li> <li>xiii) Heat cycle test</li> <li>19.6</li> <li>47</li></ul></li></ul>	ii)	Test for armouring wires/formed wires	Clause <b>7</b> , Table 6 and IS 3975	36-42
a) Tensile strength and elongation at break Table 1 7 b) Ageing in air oven Table 1 11 c) Degree of cross linking d) Hot set test Table 1 30 e) Shrinkage test Table 1 12 f) Water absorption test (gravimetric) Table 1 33 iv) Test for thickness of insulation Clause 11, Tables 4, 5 and 6 (eccentricity) and sheath 7 and Annex A v) Test on extruded semi conducting screens a) Test for strippability of semicon- ducting strippable insulation screen (when applicable) b) Volume resistivity Table 2 and Annex E vi) Physical test for outer sheath: a) Tensile strength and elongation at IS 5831 or Table 3 7 break b) Ageing in air oven IS 5831 or Table 3 11 c) Shrinkage test IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 0 f) Heat shock IS 5831 0 f) Thermal stability IS 5831 60 h) Carbon black content of polythene Table 3 32 or any other thermo sheath 33 or Table 3 32 or any other thermo sheath 34 or analytic method (by therr gravimetric analytic) vii) Thermal ageing test for complete cable 19.9 see 19.9 viii) Partial discharge test 19.2 46 ix) Bending test 50 complete cable 19.9 see 19.9 viii) Insulation resistance (volume resistivity) test Table 1 43 xii) Heat cycle test 19.5 49 yiii) Insulation resistance (volume resistivity) test Table 1 43 xii) Heat cycle test 19.5 49 yiii) Impulse withstand test 19.6 47 xiv) High voltage test for Colume test 19.7 45 with Shard test 19.6 47 xiv) High voltage test for Colume table tab	iii)	Physical test for insulation:		
b) Ageing in air oven Table 1 11 c) Degree of cross linking d) Hot set test Table 1 30 e) Shrinkage test Table 1 12 f) Water absorption test (gravimetric) Table 1 33 iv) Test for thickness of insulation Clause 11, Tables 4, 5 and 6 (eccentricity) and sheat 7 and Annex A v) Test on extruded semi conducting screens a) Test for strippability of semicon- ducting strippable insulation screen (when applicable) b) Volume resistivity Table 2 and Annex B vi) Physical test for outer sheath: a) Tensile strength and elongation at IS 5831 or Table 3 7 break b) Ageing in air oven IS 5831 or Table 3 11 c) Shrinkage test IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 12 d) Hot deformation IS 5831 14 g) Thermal stability IS 5831 60 h) Carbon black content of polythene Table 3 32 or any other thermo sheath 23 32 or any other thermo sheath 19.2 46 ix) Bending test for complete cable 19.9 see 19.9 viii) Thermal ageing test for complete cable 19.4 48 i) As a function of voltage b) As a function of temperature xi) Insulation resistance (volume resistivity) test Table 1 43 xii) Heat cycle test 19.2 46 ix) Bending test 19.3 50 x) Insulation resistance (volume resistivity) test Table 1 43 xii) Heat cycle test 19.6 47 xiv) High voltage test 19.7 45 viii) Shrain test 19.6 47 xiv) High voltage test 19.9 55 10.0 5 10.0		a) Tensile strength and elongation at break	Table 1	7
<ul> <li>c) Degree of cross linking</li> <li>d) Hot set test</li> <li>Table 1</li> <li>30</li> <li>e) Shrinkage test</li> <li>Table 1</li> <li>12</li> <li>f) Water absorption test (gravimetric)</li> <li>Table 1</li> <li>33</li> <li>iv) Test for thickness of insulation</li> <li>Clause 11, Tables 4, 5 and</li> <li>6</li> <li>(eccentricity) and sheath</li> <li>7 and Annex A</li> <li>v) Test or strippability of semicon- ducting strippable insulation screen</li> <li>a) Test for strippability of semicon- ducting strippable insulation screen</li> <li>b) Volume resistivity</li> <li>Table 2 and Annex B</li> <li>when applicable)</li> <li>b) Volume resistivity</li> <li>Table 2 and Annex E</li> <li>vi) Physical test for outer sheath: <ul> <li>a) Tensile strength and elongation at IS 5831 or Table 3</li> <li>Treak</li> <li>b) Ageing in air oven</li> <li>IS 5831 or Table 3</li> <li>11</li> <li>c) Shrinkage test</li> <li>IS 5831 or Table 3</li> <li>11</li> <li>c) Shrinkage test</li> <li>IS 5831 or Table 3</li> <li>12</li> <li>d) Hot deformation</li> <li>IS 5831 or Table 3</li> <li>15</li> <li>e) Loss of mass in air oven</li> <li>IS 5831 or Table 3</li> <li>10</li> <li>f) Heat shock</li> <li>IS 5831</li> <li>10</li> <li>h) Carbon black content of polythene Table 3</li> <li>32 or any other thermo sheath</li> <li>a) Thermal ageing test for complete cable</li> <li>19.9</li> <li>see 19.9</li> </ul> </li> <li>vii) Thermal ageing test for complete cable</li> <li>19.2</li> <li>46</li> <li>ix) Bending test</li> <li>19.3</li> <li>50</li> <li>x) Dielectric power factor test:</li> <li>a) As a function of voltage</li> <li>b) As a function of temperature</li> <li>xi) Insulation resistance (volume resistivity) test</li> <li>Table 1</li> <li>43</li> <li>xii) Heat cycle test</li> <li>19.6</li> <li>47</li> <li>xiii) Inpulse withstand test</li> <li>19.6</li> <li>47</li> <li>xiii) High voltage test</li> <li>19.7</li> <li>45</li> </ul>		b) Ageing in air oven	Table 1	11
d) Hot set test       Table 1       30         e) Shrinkage test       Table 1       12         f) Water absorption test (gravimetric)       Table 1       33         iv) Test for thickness of insulation (eccentricity) and sheath       Clause 11, Tables 4, 5 and       6         7 and Annex A       7 and Annex A       7         v) Test on extruded semi conducting screens       Table 2 and Annex B         a) Test for strippable insulation screen (when applicable)       Table 2 and Annex E         b) Volume resistivity       Table 2 and Annex E         vi) Physical test for outer sheath:       a) Tensile strength and elongation at break       IS 5831 or Table 3       11         c) Shrinkage test       IS 5831 or Table 3       11         c) Shrinkage test       IS 5831       10         f) Heat shock       IS 5831       10         g) Thermal stability       IS 5831       10         h) Carbon black content of polythene sheath       19.9       see 19.9         vii)       Partial discharge test       19.2       46         ix) Bending test       19.3       50         x)       Dielectric power factor test:       19.4       48         a) As a function of temperature       19.5       49         xi)       Ins		c) Degree of cross linking		
e) Shrinkage test Table 1 12 f) Water absorption test (gravimetric) Table 1 33 iv) Test for thickness of insulation (eccentricity) and sheath 7 and Annex A v) Test on extruded semi conducting screens a) Test for strippability of semicon- ducting strippable insulation screen (when applicable) b) Volume resistivity Table 2 and Annex E vi) Physical test for outer sheath: a) Tensile strength and elongation at IS 5831 or Table 3 7 break b) Ageing in air oven IS 5831 or Table 3 11 c) Shrinkage test IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 100 f) Heat shock IS 5831 100 h) Carbon black content of polythene sheath a) Tensile strength and elongate at 19.9 see 19.9 vii) Thermal ageing test for complete cable 19.9 see 19.9 viii) Thermal ageing test for complete cable 19.4 48 a) As a function of temperature x) Insulation resistance (volume resistivity) test Table 1 43 x) High voltage test 19.6 477 x) Will State test 19.6 477 x) Will State test 19.6 477 x) High voltage test 19.7 45		d) Hot set test	Table 1	30
f)       Water absorption test (gravimetric)       Table 1       33         iv)       Test for thickness of insulation       Clause 11, Tables 4, 5 and       6         (eccentricity) and sheath       7 and Annex A       7         v)       Test or strippablity of semicon-ducting strippable insulation screen (when applicable)       Table 2 and Annex B         b)       Volume resistivity       Table 2 and Annex E         vi)       Physical test for outer sheath:       7         a)       Testile strength and elongation at break       IS 5831 or Table 3       7         b)       Ageing in air oven       IS 5831 or Table 3       11         c)       Shrinkage test       IS 5831 or Table 3       15         e)       Loss of mass in air oven       IS 5831       10         f)       Heat shock       IS 5831       10         g)       Thermal stability       IS 5831       60         h)       Carbon black content of polythene sheath       32 or any other thermo analytic method (by therm gravimetric analysis)         vii)       Thermal ageing test for complete cable       19.9       see 19.9         viii)       Partial discharge test       19.4       48         a)       As a function of temperature       19.4       48		e) Shrinkage test	Table 1	12
iv)Test for thickness of insulation (eccentricity) and sheathClause 11, Tables 4, 5 and 7 and Annex A6v)Test on extruded semi conducting screens7 and Annex A6a)Test or strippability of semicon- ducting strippable insulation screen (when applicable)Table 2 and Annex B6b)Volume resistivityTable 2 and Annex E7vi)Physical test for outer sheath: a) Test of extrength and elongation at breakIS 5831 or Table 37b)Ageing in air ovenIS 5831 or Table 311c)Shrinkage testIS 583112d)Hot deformationIS 583113e)Loss of mass in air ovenIS 583114g)Thermal stabilityIS 583160h)Carbon black content of polythene sheathTable 332 or any other thermo analytic method (by therm gravimetric analysis)viii)Thermal ageing test for complete cable19.9see 19.9viiii)Partial discharge test19.246ix)Bending test19.350x)Dielectric power factor test: a)19.448a)As a function of voltage b)As a function of temperature43xiii)Heat cycle test19.549xiii)Impulse withstand test19.647xiv)High voltage test19.745		f) Water absorption test (gravimetric)	Table 1	33
(eccentricity) and sheath       7 and Annex A         v)       Test on extruded semi conducting screens         a)       Test for strippability of semicon- ducting strippable insulation screen (when applicable)       Table 2 and Annex B         b)       Volume resistivity       Table 2 and Annex E         vi)       Physical test for outer sheath: <ul> <li>a)</li> <li>Tensile strength and elongation at break</li> <li>b) Ageing in air oven</li> <li>IS 5831 or Table 3</li> <li>11</li> <li>c)</li> <li>Shrinkage test</li> <li>IS 5831</li> <li>12</li> <li>d)</li> <li>Hot deformation</li> <li>IS 5831</li> <li>c)</li> <li>Shrinkage test</li> <li>IS 5831</li> <li>ID</li> <li>f)</li> <li>Heat shock</li> <li>IS 5831</li> <li>ID</li> <li>f)</li> <li>Heat shock</li> <li>IS 5831</li> <li>Go rappoint and polythene sheath</li> </ul> <ul> <li>Thermal stability</li> <li>IS 5831</li> <li>Go rappoint and polythene sheath</li> <li>Thermal stability</li> <li>Stas1</li> <li>Go rappoint the sheat</li> <li>So rappoint the sheat</li> <li>So rappoint the sheat</li> <li>As a function of voltage</li> <li>b)</li> <li>As a function of temperature</li> <li>xi)</li> <li>Insulation resistance (volume resistivity) test</li> <li>Table 1</li> <li>Table 3</li> <li>As a function of temperature</li> <li>xiii)</li> <li>Impulse withstand te</li></ul>	iv)	Test for thickness of insulation	Clause 11, Tables 4, 5 and	6
<ul> <li>v) Test on extruded semi conducting screens</li> <li>a) Test for strippability of semicon- ducting strippable insulation screen (when applicable)</li> <li>b) Volume resistivity</li> <li>Table 2 and Annex E</li> <li>vi) Physical test for outer sheath: <ul> <li>a) Tensile strength and elongation at break</li> <li>b) Ageing in air oven</li> <li>IS 5831 or Table 3</li> <li>Table 2 and Annex E</li> </ul> </li> <li>vi) Physical test for outer sheath: <ul> <li>a) Tensile strength and elongation at break</li> <li>b) Ageing in air oven</li> <li>IS 5831 or Table 3</li> <li>f) Hot deformation</li> <li>IS 5831 or Table 3</li> <li>f) Heat shock</li> <li>g) Thermal stability</li> <li>f) Heat shock</li> <li>h) Carbon black content of polythene sheath</li> <li>vii) Thermal ageing test for complete cable</li> <li>19.9</li> <li>see 19.9</li> <li>viii) Partial discharge test</li> <li>ix) Bending test</li> <li>ix) Bending test</li> <li>ix) Bending test</li> <li>ix) Bending test</li> <li>ix) Bautoion of temperature</li> <li>ix) Insulation resistance (volume resistivity) test</li> <li>table 1</li> <li>43</li> <li>xii) Heat cycle test</li> <li>ix) Bending test</li> <li>ix) Insulation resistance (volume resistivity) test</li> <li>ix) Insulation tresistance (volume resistivity) test</li> <li>ix) High voltage test</li> <li>ix) Heat cycle test</li> <li>ix) High voltage test</li> <li>ix) Hig</li></ul></li></ul>		(eccentricity) and sheath	7 and Annex A	
a) Test for strippability of semicon- ducting strippable insulation screen (when applicable)       Table 2 and Annex B         b) Volume resistivity       Table 2 and Annex E         vi) Physical test for outer sheath: <ul> <li>a) Tensile strength and elongation at break</li> <li>b) Ageing in air oven</li> <li>IS 5831 or Table 3</li> <li>for the formation</li> <li>IS 5831 or Table 3</li> <li>for the formation</li> <li>IS 5831</li> <li>for the formation</li> <li>for the for</li></ul>	v)	Test on extruded semi conducting screens		
b) Volume resistivity Table 2 and Annex E vi) Physical test for outer sheath: a) Tensile strength and elongation at IS 5831 or Table 3 7 break b) Ageing in air oven IS 5831 or Table 3 11 c) Shrinkage test IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 or Table 3 15 e) Loss of mass in air oven IS 5831 10 f) Heat shock IS 5831 10 f) Heat shock IS 5831 60 h) Carbon black content of polythene Table 3 32 or any other thermo sheath 23 or any other thermo analytic method (by therm gravimetric analysis) vii) Thermal ageing test for complete cable 19.9 see 19.9 viii) Partial discharge test 19.2 46 ix) Bending test 19.3 50 x) Dielectric power factor test: 19.4 48 a) As a function of voltage b) As a function of temperature xi) Insulation resistance (volume resistivity) test Table 1 43 xii) Heat cycle test 19.6 47 xiv) High voltage test 19.7 45 with the for DVC cheated applered to the formore the formo the formole the		a) Test for strippability of semicon- ducting strippable insulation screen (when applicable)	Table 2 and Annex B	
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<ul> <li>c) Shrinkage test IS 5831 12</li> <li>d) Hot deformation IS 5831 or Table 3 15</li> <li>e) Loss of mass in air oven IS 5831 10</li> <li>f) Heat shock IS 5831 10</li> <li>f) Heat shock IS 5831 14</li> <li>g) Thermal stability IS 5831 60</li> <li>h) Carbon black content of polythene Table 3 32 or any other thermo analytic method (by therm gravimetric analysis)</li> <li>vii) Thermal ageing test for complete cable 19.9 see 19.9</li> <li>viii) Partial discharge test 19.2 46</li> <li>ix) Bending test 19.3 50</li> <li>x) Dielectric power factor test: 19.4 48</li> <li>a) As a function of voltage</li> <li>b) As a function of temperature</li> <li>xii) Insulation resistance (volume resistivity) test Table 1 43</li> <li>xiii) Heat cycle test 19.6 47</li> <li>xiv) High voltage test 19.7 45</li> <li>xv) High voltage test 19.7 45</li> </ul>		b) Ageing in air oven	IS 5831 or Table 3	11
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XIV)     Fight voltage test     19.7     45       xv)     Elementality test for DVC sheethed colles     10.9     52	x111)	High voltage test	19.0 10-7	47 45
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successively on the same test sample of completed cable not less than 10 m in length between the test accessories:

- a) Partial discharge test,
- b) Bending test followed by partial discharge test,
- c) Dielectric power factor as a function of voltage,
- d) Dielectric power factor as a function of temperature,
- e) Heating cycle test followed by dielectric

power factor as a function of voltage and partial discharge tests,

- f) Impulse withstand test, and
- g) High voltage test.

**19.1.2.1** If a sample fails in test (vii) one more sample shall be taken for this test preceded by tests (ii) and (v).

**19.1.3** The following shall constitute additional type test for the cables with improved fire performance as per the Categories given in Annex C.

Category	Test	For Requirement, Ref to Clause	<i>Methods of Test,</i> <i>Ref to IS 10810</i>
(1)	(2)	(3)	(4)
01	No additional test	_	_
C1	a) Oxygen index	20.10	58
	b) Flame retardance test on single cables	20.11	61
	c) Flame retardance test on bunched cables	20.12	62
	d) Temperature index	20.15	64
C2	a) Oxygen index	20.10	58
	b) Flame retardance test on single cables	20.11	61
	c) Flame retardance test on bunched cables	20.12	62
	d) Smoke density test (on sheathing material)	20.14	under preparation
	e) Test for halogen acid gas evolution	20.13	59
	f) Temperature index	20.15	64

NOTES

1 For Category C1 tests (a) and (d) are to be performed on sample taken from the outer sheath, as applicable and prepared in the manner given in the relevant test methods .

 ${\bf 2}$  For Category C2 test (a) , (e), and (f) are to be performed on samples taken from outer sheath , as applicable and prepared in the manner given in relevant test methods .

#### 19.2 Acceptance Tests

The following shall constitute acceptance tests:

- a) Annealing tests (for copper),
- b) Tensile test (for aluminium),
- c) Wrapping test (for aluminium),
- d) Conductor resistance tests,
- e) Test for thickness of insulation (eccentricity) and sheath,
- f) Hot set test for insulation,
- g) Tensile strength and elongation at break test for insulation and outer sheath,
- h) Partial discharge test (for screened cables only),
- j) High voltage test,
- k) Insulation resistance (volume resistivity) test, and
- m) Test for cross linking for extruded semiconducting screen.

NOTE — Partial discharge test shall be carried out on full drum length.

**19.2.1** A recommended sampling plan for acceptance test is given in Annex D.

**19.2.2** The following shall constitute additional acceptance tests for cables with improved fire performance as per the categories given in Annex C.

Category	Test
01	No additional test
C1	a) Oxygen index
	b) Flame retardance test on single cable
	c) Flame retardance on bunched cables
C2	a) Oxygen index
	b) Flame retardance test on single cable
	c) Flame retardance test on bunched
	cables
	d) Test for halogen acid gas evolution
	e) Test for smoke density

#### **19.3 Routine Tests**

The following shall constitute routine tests:

a) Conductor resistance test,

- b) Partial discharge test (for screened cables only),
- c) High voltage test, and
- d) Resistance test for armour (for mining cables) in accordance with IS 10810 (Part 42) and **17.5**.

NOTE — Partial discharge test shall be carried out on full drum length.

#### **19.4 Optional Test**

Cold impact test for outer sheath (see IS 5831).

#### **20 DETAILS OF TESTS**

#### 20.1 General

Unless otherwise stated in this standard, the test shall be carried out in accordance with appropriate part of IS 10810, taking into account additional information given in this standard.

#### **20.2 Partial Discharge Test**

The partial discharge magnitude at test voltage equal to 1.73  $U_{o}$  shall not exceed 10 pC for routine tests/ acceptance tests and 5pC for Type Tests.

#### 20.3 Bending Test

The diameter of the test cylinder shall be  $20D \pm 5$  percent where *D* is the overall diameter of the completed cable. After completing the bending operations, the test sample shall be subjected to partial discharge measurement and shall comply with the requirements given in **20.2**.

#### **20.4 Dielectric Power Factor Test**

#### **20.4.1** tan $\delta$ as a Function of Voltage

The measured value of tan  $\delta$  at  $U_{o}$  shall not exceed 0.004 and the increment of tan  $\delta$  between 0.5  $U_{o}$  and 2  $U_{o}$  shall not be more than 0.002.

#### **20.4.2** tan $\delta$ as a Function of Temperature

The measured value of tan  $\delta$  *shall* not exceed 0.004 at ambient temperature and 0.008 at 5 °C to 10 °C above the maximum conductor temperature in normal operation.

#### 20.5 Heating Cycle Test

The sample, which has been subjected to previous tests shall be laid out on the floor of the test room and heated by passing a current through the conductor, until the conductor reaches a steady temperature of  $5^{\circ}$ C to  $10^{\circ}$ C above the maximum conductor temperature in normal operation.

For three core cables, the heating current shall be passed through all conductors.

The heating cycle shall be of atleast 8 h duration. The conductor temperature shall be maintained within the stated temperature limits for atleast 2 h of each heating period. This shall be followed by atleast 3 h of natural cooling in air to a conductor temperature within 10 K of ambient temperature.

NOTES

**1** The cycle shall be carried out 20 times.

**2** After twentieth cycle, the sample shall be subjected to dielectric power factor as a function of voltage (**20.4.1**) and partial discharge test (*see* **20.2**).

#### 20.6 Impulse Withstand Test

Impulse voltage level shall be as given below:

Rated voltage, 3.8/6.6 6.35/11 11/11 12.7/22 19/33 kV Impulse volt- 60 75 95 125 170

age, kV No breakdown of insulation shall occur during the test. The temperature of the conductor shall be at 5 °C

to 10  $^{\rm o}{\rm C}$  above the maximum conductor temperature in normal operation.

#### 20.7 High Voltage Test

#### 20.7.1 Type/Acceptance Test

The cable shall withstand without breakdown an ac voltage equal to 4  $U_{\rm o}$  when applied to the sample between conductor and screen/metallic tape/armour (and between conductors in case of unscreened cable). the voltage shall be gradually increased to the specified value and maintained for a period of 4 h.

If while testing, interruption occurs during the 4 h period the test shall be prolonged to the same extent. If the interruption period exceeds 30 min, the tests shall be repeated.

#### 20.7.2 Routine Test

The cables shall withstand without any failure, the test voltages given below, when applied for a period of five minutes for each test connection:

Voltage Grade kV	Test Voltage		
Grade KV	Between Conductor and Screen/Armour kV (rms)	Between Conductor kV (rms)	
1.9/3.3	10	10	
3.8/6.6	13		
6.35/11	21		
11/11	35		
12.7/22	42		
19/33	63		

#### 20.8 Flammability Test for PVC Sheathed Cables

Period of burning after removal of the flame shall not exceed 60 s and the unaffected (uncharred) portion from the lower edge of the top clamp shall be at least 50 mm.

#### 20.9 Thermal Ageing Test for Complete Cable

This test shall be carried out to check that the insulation, non-metallic sheath and extruded semiconducting layer over the conductor and insulation are not liable to deteriorate in operation due to contact with other components in the cable.

Three pieces of complete cable about 200 mm long shall be suspended vertically and substantially in the center of the oven at least 20 mm away from each other and shall not occupy more than 2 percent of the volume of the oven. The pieces of cables shall be kept in the oven at the temperature of  $10 \pm 2^{\circ}$ C above the rated maximum normal operating conductor temperature of the cable for duration of 168 h.

The test piece of insulation and sheath from the aged piece of the cable shall be prepared and subjected to tensile strength and elongation at break.

The resistivity of the extruded semi-conducting layers shall be determined on the test piece from the aged cable sample in accordance with Annex E.

The resistivity of semi conducting screen layers measured as per Annex E shall not exceed the following values:

a) Conductor screen : $1\ 000\ \Omega$ .	)	Conductor	screen	:	1	000	Ω.	m
--	---	-----------	--------	---	---	-----	----	---

b) Insulation screen :  $500 \Omega$ . m

**20.9.1** The test results for the tensile strength and elongation at break shall comply with the values of insulation and sheath after ageing as given in Table 1 for insulation and IS 5831 for PVC outer sheath and Table 3 for thermoplastic polyethylene outer sheath.

#### 20.10 Oxygen Index Test

The test on samples of outer sheath shall be done at  $27 \pm 2^{\circ}$ C or ambient. The oxygen index shall not be less than 29.

## 20.11 Flame Retardance Test on Single Cables (for overall diameter ≤ 35 mm)

After the test, there should be no visible damages on the test specimen within 300 mm from its upper end. Mark from fixing devices, soot or changing of the colour are not considered damages.

#### 20.12 Flame Retardance Test on Bunched Cables

After burning has ceased, the cables should be wiped clean and charred or affected portion should not have

reached a height exceeding 2.5 m above the bottom edge of the burner, measured at the front and rear of the cable assembly.

NOTE — Requirements for this test are split in 3 categories that is A, B and C as described in IS 10810 (Part 62). For the purpose of this standard, category B and C test method shall be used. In the absence of any special requirements for method B, method C shall be used for both categories C1 and C2.

#### 20.13 Test for Halogen Acid Gas Evolution

The level of HCl evolved shall not exceed 20 percent by weight.

#### 20.14 Test for Smoke Density

Smoke density rating shall be 60 maximum.

#### 20.15 Test for Temperature Index

The extrapolated values of temperature at which oxygen index is 21 shall be minimum 250°C.

#### **21 IDENTIFICATION**

#### 21.1 Manufacturer's Identification

The manufacturer shall be identified throughout the length of cable by manufacturers name or trade-mark and the voltage grade and year of manufacture indented, printed or embossed or by means of a tape bearing this information. the indentation, printing or embossing shall be done only on the outer sheath.

For manufacturers' name, if none of these methods is employed or if the purchaser so desires, colour identification threads in accordance with a scheme to be approved by the Indian Standard insulation shall be employed.

#### 21.2 Cable Identification

**21.2.1** In case of cables intended for use in mines, the word 'Mining' shall be indented, printed or embossed on the outer sheath throughout the length of the cable.

**21.2.2** The special cables with improved fire performance for Category C1 and C2 shall be identified by indenting, embossing or printing the appropriate legend on the outer sheath throughout the cable length in addition to the existing marking requirements.

Type of Cable	Legend
---------------	--------

- a) Improved fire performance or FR Category C1
- b) Improved fire performance or FR-LSH Category C2

#### 21.3 Cable Code

The following code shall be used for designating the cable:

Sl No.	Constitute	Code	Letter
i)	Aluminium conductor	I	4
ii)	XLPE insulation	2	2X
iii)	Steel round wire armour	V	N
iv)	Non-magnetic round wire armore	ur V	Wa
v)	Steel strip armour	F	7
vi)	Non-magnetic strip armour	F	Fa
vii)	Double steel round wire armour	V	WW
viii)	Double steel strip armour	F	ŦF
ix)	PVC outer sheath		Y
x)	Polyethylene outer sheath	2	2Y

NOTE — No code letter for conductor is required when the conductor material is copper.

#### 22 PACKING AND MARKING

**22.1** The cable shall be wound on a drum either wooden (*see* IS 10418) or steel and packed. The ends of the cable shall be sealed by of non-hygroscopic sealing material.

**22.2** The cable shall carry the following information either stenciled on the drum or contained in a label attached to it:

a) Reference to this Indian Standard, for example, *see* IS 7098 (Part 2);

- b) Manufacturer's name or trade-mark;
- c) Type of cable and voltage grade;
- d) Number of cores;
- e) Nominal cross-sectional area of conductor;
- f) Cable code;
- g) Length of cable on the drum;
- h) Number of lengths on the drum (if more than one);
- j) Direction of rotation of drum (by means of an arrow);
- k) Gross mass;
- m) Country of manufacture; and
- n) Year of manufacture.

#### 22.2.1 BIS Certification Marking

The cable (drum or label) may also be marked with the Standard Mark.

**22.2.1.1** The use of the Standard Mark is governed by the provisions of the *Bureau of Indian Standards Act*, 1986 and the Rules and Regulations made there under. The details of conditions under which the licence for the use of the Standard Mark may be granted to manufacturers or producers maybe obtained from the Bureau of Indian Standards.

### ANNEX A

### (*Clauses* 1.4 and 12.4)

#### TEST METHODS FOR ECCENTRICITY AND OVALITY

#### A-1 TEST METHOD FOR ECCENTRICITY

The eccentricity of the insulation shall be checked as follows:

Percent eccentricity = 
$$\frac{t_{\text{Max}} - t_{\text{Min}}}{t_{\text{Max}}} \times 100$$

where *t* stands for the thickness of insulation.

#### **A-2 TEST METHOD FOR OVALITY**

The ovality of the core shall be checked as follows:

Percent ovality = 
$$\frac{d_{\text{core Max}} - d_{\text{core Min}}}{d_{\text{core Max}}} \times 100$$

where d stands for the diameter of the core.

#### ANNEX B

#### (*Clause* 13.3)

#### STRIPPABILITY TEST FOR STRIPPABLE SEMICONDUCTING INSULATION SCREEN

**B-1** This test shall be carried out when extruded semiconducting insulation screen is strippable.

The test shall be performed three times on both unaged and aged samples, using either three separate pieces of cable or one piece of cable at three positions around the circumstance, spaced at approximately  $120^{\circ}C$ 

Core lengths of atleast 250 mm shall be taken from the cable to be tested, before and after being aged according to 20.9.

Two cuts shall be made in the extruded semiconducting insulation screen of each sample, longitudinally from end to end and radially down to the insulation, the cuts being  $(10 \pm 1)$  mm apart and parallel to each other.

After removing approximately 50 mm length of the 10 mm strip by pulling it in a direction parallel to

the core (that is, a stripping angle of approximately 180°C), the core shall be mounted vertically in a tensile machine with one end of the core held in one grip and the 10 mm strip in the other.

The force to separate the 10 mm strip from the insulation, removing a length of atleast 100 mm, shall be measured at a stripping angle of approximately 180 °C. Using a pulling speed of  $250 \pm 50$  mm/min.

The test shall be carried out at a temperature of  $27 \pm 5$  °C.

For unaged and aged samples, the stripping force values shall be continuously recorded.

The insulation surface shall not be damaged and no trace of the semiconducting screen shall remain on the insulation.

## ANNEX C

## (Clauses 19.1.3 and 19.2.2)

#### Category **Environment Description** Type Cable Description 01 Cables in open areas Flame retardant, single cable self extinguishing, does not propagate fire C1 Cables in constrained area FR Flame retardant, does not propagate fire even when installed in groups in vertical ducts C2 Cables in constrained area with limited FR-LSH Flame retardant cables with reduced human activities and/or presence of halogen evolution and smoke sophisticated system

#### CATEGORIES OF CABLES WITH IMPROVED FIRE PERFORMANCE

### ANNEX D

(Clause 19.2.1)

#### SAMPLING OF CABLES

#### D-1 LOT

#### **D-2 SCALE OF SAMPLING**

**D-1.1** In any consignment the cables of the same size manufactured under essentially similar conditions of production shall be grouped together to constitute a lot.

**D-2.1** Samples shall be taken and tested from each lot for ascertaining the conformity of the lot of the standard.

Sl No.	No. of Drums in a Lot	No. of Drums to be taken as Sample	Permissible No. of Defective
(1)	(2)	(3)	(4)
i)	Up to 25	3	0
ii)	26 to 50	5	0
iii)	51 to 100	8	0
iv)	101 to 300	13	1
v)	301 and above	20	1

**D-2.2** The number of samples to be selected shall be as given below:

D-2.2.1 These samples shall be taken at random. In

order to ensure the randomness of selection, procedure given in IS 4905 may be followed.

#### D-3 NUMBER OF TESTS AND CRITERION FOR CONFORMITY

**D-3.1** From each of the drums selected, suitable lengths of test samples shall be taken. These test samples shall be subjected to each of the acceptance tests (*see* **19.2**). A test sample is called defective if it fails in any one of the acceptance tests. If the number of defectives is less than or equal to the corresponding permissible number given in **D-2.2**, the lot shall be declared as conforming to the requirements of acceptance tests otherwise not.

## ANNEX E

#### (Clause 20.9)

#### METHOD OF MEASURING RESISTIVITY OF SEMICONDUCTING SCREEN

**E-1** Each test piece shall be prepared from a 150 mm sample of complete cable.

The conductor screen test piece shall be prepared by cutting a sample of core in half longitudinally and removing the conductor and separator, if any. The insulation screen test piece shall be prepared by removing all the covering from the sample of the core.

The procedure for determining the volume resistivity of screen shall be as follows:

Four silver plated electrodes *A*, *B*, *C* and *D* (*see* Fig. 1) shall be applied to the semi-conducting surfaces. The potential electrodes B and C shall be 50 mm apart and the two current electrodes A and D shall be each placed at least 25 mm beyond the potential electrodes.

Connection shall be made to the electrodes by means of suitable clips. In making connections to the conductor screen electrodes, it shall be ensured that the clips are insulated from the insulation screen on the outer surface of the test sample.

The assembly shall be placed in an above preheated to the specified temperature and, after an interval of at least 30 min, the resistance between the electrodes shall be measured by means of circuit, the power of which shall not exceed 100 mW.

After the electrical measurements, the diameters over the conductor screen and insulation screen and the thicknesses of the conductor screen and insulation screen shall be measured at ambient temperature, each being the average of six measurements made on the sample shown in Fig. 1.

The volume resistivity  $\rho$  in  $\Omega$  m shall be calculated as follows:

a) Conductor screen

$$\rho_{\rm c} = \frac{R_{\rm c} \times \pi \times (D_{\rm c} - T_{\rm c}) \times T_{\rm c}}{2L_{\rm c}}$$

where

 $\rho_c$  = volume resistivity, in  $\Omega$  m;

 $R_{\rm c}$  = measured resistance, in  $\Omega$ ;

- $D_{\rm c}$  = outer diameter over the conductor screen, in m;
- $L_{\rm c}$  = distance between potential electrodes, in m; and
- $T_{\rm c}$  = average thickness of conductor screen, in m.
- b) Insulation screen

$$\rho_{\rm i} = \frac{R_{\rm i} \times \pi \times (D_{\rm i} + T_{\rm i}) \times T_{\rm i}}{L_{\rm i}}$$

where

 $\rho_i$  = volume resistivity, in  $\Omega$  m;

- $R_{\rm i}$  = measured resistance, in  $\Omega$ ;
- D<sub>i</sub> = outer diameter over the insulation screen, in m;
- $L_i$  = distance between potential electrodes, in m; and
- $T_i$  = average thickness of insulation screen, in m.



All dimensions in millimetres.

Fig. 1

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